Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/700,485	NGUYEN ET AL.	
Examiner	Art Unit	
Daniel Pan	2183	

Daniel Pan

SEARCHED				
Class	Subclass	Date	Examiner	
712	206 239 245	8/21/2007	DP	
,				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOT (INCLUDING SEARCH)
	DATE	EXMR
west pgp uspat jpoabs derwent IEEE NPL IBM TD 712/227,240,230	8/21/2007	DP
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